POWDER DEFERACTION TELE

Set 40

Inongania and Organia

POWDER DIFFRACTION FILE

Set 40

Inorganic and Organic

Compiled by the JCPDS—International Centre for Diffraction Data in cooperation with the American Ceramic Society, American Crystallographic Association, American Society for Testing and Materials, Australian X-Ray Analytical Association. British Crystallographic Association, The Clay Minerals Society Deutsche Mineralogische Gesellschaft, The Institute of Physics. The Mineralogical Association of Canada, The Mineralogical Society of Great Britain and Ireland, and Société Française de Minéralogie et de Cristallographie.

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Preface

The diffraction patterns in Set 40 have been reviewed by use of NBS *AIDS83, a program for crystallographic data evaluation. This program is also used to build a computer readable data base from which the card images in Set 40 have been produced by photocomposition. For further information see INORGANIC PHASES—ALPHABETICAL INDEXES.

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EXPLANATION OF THE DATA CARD FORMAT*

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The data card shown above has spaces numbered from 1 to 9 inclusive. An explanation of the symbols in the various spaces is given below. Data added by the Editor are enclosed in square brackets.

Space 1—The location of the identification number of the card, referred to as the PDF (Powder Diffraction File) number. Should a pattern require two cards, the second card is indicated with a lower case letter "a" following the PDF number.

Space 2—Chemical formula and name of the specimen. The nomenclature follows, in general, the 1957 IUPAC Nomenclature of Inorganic Chemistry (J. Am. Chem. Soc. 82, 5523 (1960)). Specifically, for the names and formulas of compounds, cations are arranged in order of increasing valence (IUPAC Sect. 6.321) and, within a valence group, are arranged in alphabetical order (compare Sect. 6.322). Anions are placed in the following order: O², single elements, multiple elements H⁻, OH⁻. The following rules of nomenclature apply to all sets from and including Set 20, plus all future revision sets and to all indexes.

1. The names for monatomic anions shall consist of the name of the element with the termination -ide.

H-	hydride	Se ² .	selenide
D-	deuteride	Te ²	telluride
F-	fluoride	N3 -	nitride
CI -	chloride	P3 -	phosphide
Br-	bromide	As ³	arsenide `
Ι-	iodide	C4	carbide
O_2	oxide	Si ⁴⁻	silicide
S2 -	sulfide	. B ³	boride

^{*}Note: This explanation corresponds to cards in Sets 34 and above whose format has been revised from the format of earlier sets.

2. The names of certain polyatomic anions have names ending in -ide.

```
OH - hydroxide
N<sub>3</sub> - azide
NH<sup>2</sup> - imide
NH<sub>2</sub> - amide
N<sub>2</sub>H<sub>3</sub> - hydrazide
CN - cyanide
C<sub>2</sub> - acetylide
CN<sub>2</sub> - cyanamide
O<sub>3</sub> - ozonide
```

- 3. No prefixes indicating proportions shall be used.
- 4. The suffix -ate will be applied to negatively charged complexes formed from B, C, N, O, F, Si, P, S, Cl, As, Se, Br, Te, I, or At with oxygen. The suffix -ite will be used in the following cases only.

```
\begin{array}{ll} NO_2^-\\ N_2O_2^2^- \end{array} \  \, \text{nitrite} \\ \\ PO_3^3^-\\ P_2O_5^4^- \end{array} \  \, \text{phosphite} \\ \\ SO_3^2^-\\ S_2O_2^2^-\\ S_2O_4^2^- \end{array} \  \, \text{sulfite} \\ \\ S_2O_2^2^-\\ S_2O_2^2^-\\ SeO_3^2^- \  \, \text{selenite} \\ SeO_3^2^- \  \, \text{selenite} \\ CIO_2^- \  \, \text{chlorite—correspondingly with} \\ CIO^- \  \, \text{other halogens} \end{array}
```

Prefixes indicating oxidation state (hypo, per, etc.) or water content (meta, pyro ..., etc.) will not be used.

For polyatomic anions other than those mentioned, the central atom shall be named first, then the atoms and groups attached to it. That is, the apparent positive ion shall be given its name then the attached anions; e.g., SiF_6^{2-} Silicon Fluoride. Certain anionic combination names shall be retained, SCN, thiocyanate; CNO, cyanate; CN, cyanogen; and CS_3 , thiocarbonate.

Certain radicals containing oxygen have special names ending in -yl and these shall be used as follows:

но	hydroxyl	' SeO	seleninyl
CO	carbonyl	SeO ₂	selenonyl
NO	nitrosyl	CrO ₂	chromyl
NO_2	nitryl	UO ₂	uranyl
PO	phosphoryl	NpO ₂	neptunyl
VO	vanadyl	PuO ₂	plutonyl similarly for the actinides
SO	sulfinyl	CIO	chlorosyl
SO_2	sulfonyl	ClO ₂	chloryl and similarly for other halogens
S_2O_5	sulfuryl		,

The above mentioned polyatomic radicals always are treated as forming the positive part of the compound.

- 6. Acids containing more than two elements, one of which is oxygen, will be named hydrogen -ate subject to the rule for applying the suffix -ate mentioned above.
 - 7. Oxonium shall be used for a hydrated proton H₃O+.
 - 8. Aqua shall be used for water co-ordinately bound to a specific ion.

RULES OF ORDER

- 1. Alloy names are arranged in alphabetical order of the element, regardless of the order of the elements in the formulae.
- 2. Cation names, except hydrogen, shall be arranged in order of increasing valence with polyatomic cation names at the end of their appropriate valence group, except ammine or aqua which shall follow the cation with which it is associated.
- The cation names of each valence group shall be arranged alphabetically except for the polyatomic cations as described above.
 - 4. Anion names shall be arranged in the order:
 - A. Oxide
 - B. Other simple anions (containing one element only) alphabetically except hydride
 - C. Polyatomic inorganic anions, alphabetically
 - D. Organic, alphabetically
 - E. Hydride
 - F. Hydroxide
 - Ġ. Hydrate
- Space 3—"Dot" or structural formula for the specimen when available, above the mineralogical name, if any. Mineral nomenclature follows that established by the International Mineralogical Association. [NR] following a mineral name indicates a name which has not been recognized by the International Mineralogical Association.

Space 4—EXPERIMENTAL CONDITIONS

Rad-Source of the x-rays.

λ--Wavelength of x-rays used in angstroms.

Filter-Substance used to filter out extraneous wavelengths.

d-sp—Method used to measure interplanar spacings. (Guin. = Guinier; D.S. = Debye-Scherrer; Mono. = Monochromator; Diff. = Diffractometer; S.S. Det. = Solid State Detector)

Cut off-Maximum spacing possible with the apparatus used.

Int.—Method used to measure intensities.

1/1 cor.—Ratio of the intensity of the strongest line of the pattern to the intensity of the strongest line of corundum.

Ref.—Source of the data listed in Spaces 4 and 9.

Space 5—PHYSICAL DATA

Sys.—Crystallographic system to which the sample belongs.

S.G.—The three dimensional space group symbol and, in parentheses, the number of the space group as given in "International Tables for X-ray Crystallography" pp 545-553 (1952).

a, b, and c-Lattice parameters in angstroms.

A = a/b, C = c/b (or c/a for tetragonal, hexagonal or rhombohedral)—Crystal data determinative ratios.

α, β, y-Interaxial angles.

Z— The number of chemical formula units per unit of structure. For chemical elements, Z represents the number of atoms per unit of structure; for compounds, Z represents the number of formula units per unit cell.

mp-melting point.

Ref.- Source of data listed in Space 5.

Dx-Density calculated from x-ray measurements by the NBS*AIDS83 program.

Dni-Measured density.

SS/FOM—Smith-Snyder figure of merit. (For further information, see page xiii.)

Space 6—OPTICAL DATA

(Note: If no optical data is given, Space 6 will not appear.) $\epsilon\alpha$, $\eta\omega\beta$, and $\epsilon\gamma$ —Indices of refraction.

Sign—An indicator of the relationship of the intermediate index of refraction to the maximum and minimum indices of refraction.

2V--Angle between optic axes in biaxial crystals.

Ref.-Source of data listed in Space 6.

Space 7—GENERAL COMMENTS

Further pertinent information such as color, chemical analysis of the sample, source of the sample, heat treatment, temperature at which pattern was taken, Crystal Data cell (if different from author's cell in Space 5), CAS number, Merck Index number, PSC (Pearson Symbol Code), etc.

Space 8—Quality mark assigned to the pattern by the Editor. (Note: Due to the review of the Powder Diffraction File by the use of NBS*AIDS83, the quality of many patterns has been reassessed and may no longer be equivalent to that originally assigned.)

Ouality Mark Guidelines

In assigning the data quality mark, the editor is assisted by the evaluation provided by NBS*AIDS83. For patterns with more than 20 reflections, the evaluation only considers reflections out to 90° 20 whose intensities are greater than or equal to 5. For patterns with a smaller number of reflections, different ranges are used. If there are 10 reflections out to 120° 20 whose intensity values are greater than or equal to 2, these reflections are used. Otherwise, all reflections out to 180° 20 are considered regardless of intensity.

For a '*' mark:

- 1. Chemistry well characterized.
- Intensity must be measured objectively, instrumentally; no visual estimation is allowed.
- 3. Good range and even spread of intensity.
- 4. Completeness of a pattern should be sensible when factors such as pseudo symmetry are taken into account. (N_{pss} and N_{obs} provide one measure of completeness.)
- Every line with d ≤ 2.50Å must retain at least three significant digits after the decimal point. Lines with d ≤ 1.200Å must retain at least 4 significant digits after the decimal point.
- 6. No serious systematic error.
- No qualifying line may have | Δ2θ | ≥ 0.05°. In the case of multiple indexed reflections, only the minimum | Δ2θ | will be considered.
- 8. For qualifying lines the average, absolute delta two-theta value ($(\overline{\Delta 2\theta})$) must be $\approx 0.03^{\circ}$.
- 9. No unindexed; space group extinct or impurity lines.

For an 'i' mark:

- Reasonable range and even spread of intensity.
- 2. Completeness of the pattern should again be sensible.
- 3. Lines with $d \le 2.00 \text{\AA}$ must retain at least 3 significant digits after the decimal point.

- 4. No serious systematic error.
- 5 No qualifying lines may have $1\Delta2\theta 1 \geq 0.20^\circ$. (Note again $1 \geq I_{lim}$, $2\theta \geq 2\theta_{lim}$ and the same consideration for multiple reflections.)
- 6. $|\Delta 20| \le 0.06$.
- Maximum number of unindexed, space group extinct or impurity lines is = 2, but none of those should pertain to the strongest eight.

For an 'O' mark:

This quality mark is assigned by the editor to indicate: (1) data of low precision or, (2) data likely or possibly due to a multiphase mixture or, (3) data from a phase poorly characterized chemically. The 'O' mark is commonly assigned to patterns without a cell unless qualifying information indicates a single phase material. Usually, the editor will insert a comment in space 7 to explain why an 'O' was assigned.

For patterns with a unit cell, the following criteria can be used to suggest the presence of two or more phases:

- 1. Number of unindexed, space group extinct or impurity lines is 3 or more.
- 2. One of the three strongest lines is unindexed.

For a blank mark:

For patterns which do not meet the criteria for '*', 'i', or 'O'.

For a 'C' mark

The 'C' mark is used to indicate that the powder pattern was calculated from structural parameters. The structure refinement R-factor should be ≤ 0.10 . In addition, the F_{calc} should be checked against $||F_{obs}||$. Alternatively, a complete check of the bond distances and angles should have been made. If the structure is derived by Rietveld methods, the calculated pattern will be accepted only in unusual cases. The required number of significant digits is also the same as for a '*'.

Space 9—Columns of interplanar spacings, relative intensities, and Miller indices. The three strongest reflections will appear in bold face. The following abbreviations may be used in Space 9:

- b-broad, fuzzy or diffuse line
- n-index not permitted by given space group
- x—intensity uncertain due to the presence or overlap of β lines
- + -additional indices possible
- c-calculated by NBS+AIDS83

Figure of Merit

A figure of merit, when available, is indicated in space 5 of the Powder Diffraction File data card. The figure of merit generally used is that reported by Smith and Snyder (1979) which indicates the completeness and accuracy of measured interplanar spacings.

This figure of merit, FN, is defined as:

$$F_{N} = \left(\frac{1}{|\Delta 2\theta|}\right) \left(\frac{N}{N_{poss}}\right)$$

where $|\Delta 2\theta|$ is the average absolute discrepancy between observed and calculated 2θ values and N_{poss} is the number of independent diffraction lines possible up to the Nth observed line.

Some comments for the counting of possible diffraction lines are:

Systematic absences caused by symmetry elements and lattice type are excluded in the tallying of N_{poss}.

Only one plane from the complete set of planes related by crystal symmetry is counted in N_{poss}. For example, in the cubic system, the 100 line is counted as one independent line although it is composed of diffracted intensities from all six planes of that crystallographic form.

Some forms, though not related by symmetry, have exactly the same spacing and would give rise to the same line in the powder pattern e.g., (333) and (511) in the cubic system. Forms of this kind are also counted as one independent line. Note that this rule means that the higher-symmetry Laue group of a crystal system is always assumed. When a lower-symmetry Laue group is definitely known from single crystal studies, (e.g. tetragonal, Laue group 4/m) many pairs of lines, not related by symmetry, occur with exactly the same spacings e.g. (420), (240). All these pairs are treated as single lines.

For the case of accidental degeneracy (i.e., nonequivalent forms which have spacings so nearly identical that the individual lines would not be experimentally resolved), all lines in such a cluster are counted as possible independent lines thereby increasing N_{poss} . Each author assigned hkl is used in the calculation of $|\Delta 2\theta|$ even when two or more hkl's are assigned to a single observed spacing.

The format used in reporting FN is FN = overall value of FN ($\overline{1\Delta 2\theta}$ 1, N_{poss}), where N, the number of observed reflections is chosen as thirty, or the maximum number of lines of the pattern if less than thirty.

References

Smith, G. S. and Snyder, R. J., J. Appl. Cryst., 12, 60 (1979)

Inorganic Section

40-1

∏ ₇ (CrO ₂) ₃	d.A	Int	bki	dÀ	Int	haki
h	6.38	30	200	·		
Thallium Chromium Oxide	5.53	-0	111		1	
Indiana Caronipan Gales	4.424	30	211	ł	i i	
	4.313	70 '	002		1	
ad. CuKa, à 1.5405 Filter Beta d-sp D.S.	4.082	10	102		1 1	
at off Int. Visual VIcor.	3.834	10	310		1 1	
er. Cubennet. 1 Private Communication	3.704	20	112		1 1	
	3.580	10	202	ŀ		
ys. Orthorhombic S.G. Pbcn (60)	3.517	5	311		1 1	
12.805 b 3.776 c 8.651 A C	3.324	5	212	l	1 1	
Bel. Lecerf. A. et al. C. R. Seances Acad. Sci., Ser. 2, 296 1047	3.198	10	400	ı	1 1	
1983)	3.038	50	302		1	
D_{\bullet} 5.170 D_{\bullet} 5.060 SS/FOM $F_{24} = 6(.058.64)$	2.988	30	122		i i	
	2.831	80	411			
Color Red-brown	2.672	100	.113		1	
Made by reacting CrO ₃ and $\Pi(NO_3)_3$: 3H ₂ O at 40 C and washing	2.570	20	402	1	1 1	
onth acetone. C.D. Cell: $a = 6.76$, $b = 12.305$, $c = 8.051$, $a/b = 0.0854$.	2.518	30	213	Į.	1	
/b = 0.6756. S.G. = Pcan (60). PSC. oP68.	2.486	10	421		1 :	
	2.370	50	123.511	t	1 1	
	2.167	10	904		1 1	
	2.137	40	512.600		1 1	
	2.090	10	431	1	1	
	2.047	10	204	1	1 1	
	2.016	30	241		1 1	

40-2

₩U-Z						
La ₂ MnO _{4,15}	dÅ	int	habi.	d Å	Int	
Lanthanum Manganese Oxide Rad. CuKa \(\lambda\) 1.5418 Filter 4-ap	3.779 3.207 2.905 2.821 2.775	35 15 100 30	111 004 113 300 020	1.392 1.341 1.292 1.282 1.277	4 2 <1 <1	208.028 119 404 0010 317
Test off 2.1 Inst. Ins	2.545 2.153 2.138 2.119 2.100 1.980 1.389 1.764	2 15 20 15 15 15 30 1	022 115 006 204 024 220 222 311	1.273 1.269 1.260 1.258 1.245	<1 1 5 3 4	044 137 333 420 228.240
Made by heating LaMnO ₃ in a reducing atmosphere near 1380 C. C.D. Cell: a = 5.642, b = 12.830, c = 5.550, a/b = 0.4398, c/b = 0.4326, oF?.	1.741 1.703 1.694 1.684 1.663 1.645 1.626 1.604 1.463 1.453 1.450	10 12 12 15 20 15 20 15	131 206 026 224 117 313 133 008 315 226 135			

40-3

TI ₄ SiW ₁₂ O ₄₆ ·SH ₂ O	dA	Int	bici	dÀ	int	bkl-
Thallium Tungsten Silicate Hvdrate	8.31 6.76 4.7 7	40 30 60	110 111 211			
Rad. CuKα ₁ λ 1.5406 Filter Ni d-sp Diff. Cut off Int. Visual Ref. Varfolomeer, M. et al., Russ. J Inorg. Chem. IEngl. Transl.). 27 1750 (1982) Sys. Cubic a 11.65(1) b c A C a β γ Z mp Ref. Ibid. D _x SS/FOM F ₁₅ = 7(.050,43)	3.68 3.36 2.91 2.74 2.49 2.38 2.29 2.13 2.06 1.891	60 60 100 60 40 60 30 40 40	310 222 400 411 332 422 510 521 440 611		E	
Made by adding an aqueous solution of TINO ₃ to one of H ₂ SiW ₁₂ O ₃₀ and heating to 80 C. Cs ₃ SiW ₁₂ O ₃₀ -8H ₂ O type. PSC: P?.	1.756 1.649	40	622 550			

0-4 40-4

TLSIW ₁₂ O	dÀ	Int	hkl	Ab	int	int.
Thallium Tungsten Silicate	8.36 6.83 4.83	40 30 60	110 111 211			i i
ad. CuKa k 1.5418 Filter Mono. d-sp Guinier mt off hat. Visuai Ul _{east.} ef. Varfolomeer. M. et al., Russ. J. Inorg. Chem. (Engl. Transl.), 1750 (1982)	3.73 3.40 2.95 2.77	60 30 40	310 222 400 411 332			
ys. Cubic S.G. P*3* 11.78 b c A C 2 mp ef. 1bid.	2.51 2.40 2.31 2.14 2.08	30 40 40	422 510 [521] 440			
D_{x} D_{m} SS/FOM $F_{13} = o(.065,33)$	1.906	+0	611		i	
attern at 450 C. Made by hearing $\Pi_4 SiW_{12}O_{40}$ -8 H_2O at 450 C. $C_8 SiW_{12}O_{40}$ (ype. PSC. cP?						
y						
	i			l		

40-5

i

T12W6O19	dA	int	hki	dA	Int	hki
Thallium Tungsten Oxide	6.45 3.84 3.30	60 80 80	110 002 022.112			
Rad. CuKa à 1.5418 Filter Mono. d-sp Guinter Cut off Int. Visual Ul _{cos} . Ref. Varfolemeer, M. et al., Russ. J. Inorg. Chem. (Engl. Transl.). 27 1750 (1982)	3.25 3.20 2.68 2.66	60 100 40 60	040 220 132 202 042			
Sys. Orthorhombic S.G. C a 7.38(2) b 12.99(3) c 7.68(2) A C α β γ Z mp Ref. Ibid.	2.483 2.460 2.060 1.921 1.869	60 60 60	222 331.242 004 260			
D_{x} D_{m} SS/FOM $F_{13} = 3(.035.47)$	1.839	60	114			
Pattern at 760 C, K-W ₂ O ₁₉ type C,D, Cell; a = 7,680, b = 12,990, c = 7,380, a/b = 0,5912, cb = 9,5681, S,G, = A, PSC; oC?.						
					1	1
-						

40-6

ď

AgLaSb ₂ O ₇	dÅ	Int	hki	dÅ	Int	biki
Silver Lanthanum Antimony Oxide	5.19 3.076 3.003	100 95	002 022 202			*
Rad. CuKa A 1.5418 Filter d-sp Diff. Cut off Int. Diffractometer M _{coef.} Ref. Lopatin. S. et al., Russ. J. Inory Chem, Engl. Transt. J. 27 1559 (1982)	2.663 2.570 2.394 2.353 2.049	47 20 2 2 2 3	220 [004] 301 131* 033	×		
Sys. Orthorhombic S.G. 12mm (44) a 7.391 b 7.679 c 10.271 A C α β γ Z 4 mp' Ref. Ibid. D _x 6.862 D _m SS/FOM F ₂₁ =5(.036.129)	1.919 1.850 1.616 1.584 1.563	11 60 20 20 9	040 · 224 · 242 · 422 · 026 · .		2	
Color Yellow Made by heating AgSbO ₃ and LaSbO ₄ for 7 hours at 900 C and at 1000-1150 C in air. Weberite. AlF ₂ MgNa ₂ type. C.D. Cell: $a=7.679$. $b=10.271$, $c=7.391$, $ab=0.7476$, $cb=0.7196$. S.G. = Imm2 (44). "Not permitted by space group. External standard used. PSC: ol44.	1.554 1.537 1.500 1.330 1.242 1.207 1.194 1.181 1.173	9 8 8 5 3 7 7 5 3	206 044 404 440 062 246 426 444 620	5. N		
		5				

40-7

Zinc Silicate Zinc Silicate Zinc Silicate Rad.	10 25 40 40 85 25 40 25 85 100 10 25 40	110 200 210 030 300 002 012 102 112 320 022 140		
Second	85 25 40 25 85 100 10 25	300 002 012 102 112 320 022 140	÷	
iys. Orthorhombic S.G. P*** 3. 9.085(10) b 10.625(8) c 5.962(4) A 0.8551 C 0.5611 2.633 2. mp Z mp 2.633 Ref. Ibid. 2.553 D _x D _m SS/FOM F ₂₁ = 4(.041.137) 2.525 2.52	85 100 10 25	320 022 140	-	
$D_{x} = D_{yx} = SS/FOM / F_{11} = 4(.041.137)$ 2.507				
2.401 2.07 2.07 2.07 2.07 2.07 2.07 2.07 2.07	85 55 40 10 70 70	231 122 212,041 321 302,401 312 150 133		

40-8

PO314-10H2O	dA	Int	bki	d Å	fat	hki
CuK\alpha_1 \text{1.5406} Filter	9.02 9.02 8.08 6.39 5.79 5.05 5.02 4.87 4.55 4.43 3.209 3.364 3.209 3.172 3.264 3.209 3.172 3.264 3.202 2.805 2.763 2.763 2.7763 2.734 2.670	100 20 20 9 50 8 8 10 5 5 5 5 5 5 6 3 7 7 4 9 5 5 7 5 3 4	020 110 011 011 120 021 101 130 111 031 040 121 141 150 051 231 241 060 232 160	2.610 2.596	8 10	052 161

40-9						_ X
Ma ₃ (PO ₃) ₄ ·10H ₂ O	d A	int	iski	dÅ	int	hki
Manganese Phosphate Hydrate Rad. CuKa \(\lambda \) 1.5418 Filter d-sp Diff. Cut off 22.1 Int. Diffractometer \(\bar{M_{query}} \) Ref. Ei-Horr. N Duniff, C. R. Seances Acad. Sci., Ser. 2, 296 1185 (1983)	8.86 7.88 6.74 6.24 5.64 5.34	50 65 40 65 35	020 110 011 111.120 021 121 130	2.715 2.668 2.625 2.595 2.547 2.521 2.519	6 16 10 30 30 30 14	331 242 330 322 103 113 142
S.G. $P2 / n$ (14) a 9.219(4) b 17.733(8) c 7.644(3) A 0.5199 C 0.4311 a β 107.37(2) γ Z 2 mp Ref. Ibid. D _x 2.280 D ₃₈ SS/FOM F ₃₀ = 34(.012.72) Isostructural with the Ca and Cd salts. PSC: mP114.	4.59 4.43 4.40 4.27 3.936 3.593 3.573 3.530 3.341 3.292 3.130 3.057 3.013 2.803 2.803 2.761	25 70 95 45 95 12 35 35 60 45 9 35 30 40 13 100 60 25 9	031 040, 131 200 210, 211 221 131 002 012 230 202 211 132 151 301 311 122, 310 160 250, 251	2.514	13	341

Can(Mn(OH)al)	dÅ	Int	hiki	dÅ	Int	bki
Ca ₃ (Mn(OH) ₆ l ₂ Calcium Manganese Hydroxide Rad. CuKa: \(\lambda \) 1.5418 Filter Ni	5.077 4 307 3.169 2.781 2.439 2.271 2.018 1.966 1.919 1.795 1.795 1.092 1.662 1.554	50 50 85 60 100 30 45 60 10 25 15 12 10 85 10	hki 211 220 440 420 420 431 521 620 541 441 642 800	dÅ	Int	bki

4V-11						
Sra[Mn(OH) ₆] ₂	dÅ	Int	hki	dÁ	Int	hki
Strontium Manganese Hydroxide	5.26 3.443 3.220	40 40 35	211 321 400			
tad. CuKa k 1.5418 Filter Ni d-ap Diff. lat. Diffractometer ltl. ees. (vanor-Emin. B. et al Russ. J. Inorg. Chem. (Engl. Transt.). 7 (1755 (1982)	2.881 2.630 2.350 2.090	100 60 35 35 25	420 422 [521] 611			
ys. Cubic S.G. Ia3d (230) 12.382(5) b c A C β γ Z S sup	1.786 1.753 1.722	10 35	640 721 642	2		
$D_{x} = 3.585$ $D_{m} = SS/FOM F_{10} = 58(.009.19)$		1				
Color Brown Aade by reaction of manganese acetate with SrCl ₃ in NaOH solu- ion. Hydrogarnet type, PSC: cl232.						
			(8)			
•	1					
	1	1 1		Ì		

40-12

a-CaSr ₂ WO ₆	dÁ	Int	bkl	dÁ	lmt	hki
Calcium Strontium Tungsten Oxide	4.755 4.729 4.111	25 25 6	101 110 011.200			
Rad. CoKa \(\lambda \) 1.7902 Filter d-sp Diff. Cut off lut. Diffractometer U _{1-cut} . Ref. Zhemgmin. F. et al. Sci. Sin. (Engi. Ed.). 26 835 (1983) Sys. Orthorhombic S.G. Pmm2 (25) a 8 2033 b 5.7676 c 5.8489 A C	3.672 2.9224 2.9014 2.8818 2.7516 2.6190 2.4822	30 100 25 2 1	002 211 020 102 012 112			٠
α β γ Z 2 mp Ref. 1bid. D _X 5.943 D _m 5.981 SS/FOM F ₁₂ = 9(.056.23)	2.4674 2.3830	19 1	301.310 202			
Low temperature form. CaSr ₂ WO ₆ is cubic above 860 C. C.D. Cell: a=5.849, b=8.203, c=5.768, a/b=0.7130, c/b=0.7031, S.G. = P2mm (25), PSC: oP20.			î			